

Dosimetry with thin silicon detectors

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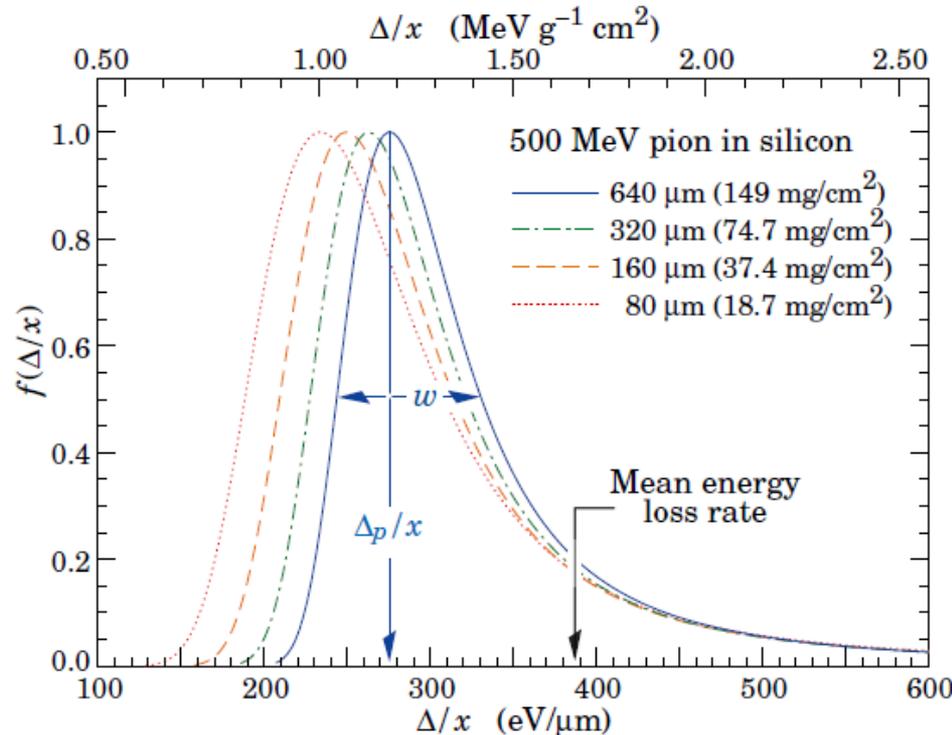
Main Topics

- **Calibration**
- **Vavilov/Landau vs. Bethe**
- **Converting Si dose to tissue dose**
 - **Modeling**
 - **Insights from RAD (with caveats)**

LET: Measured vs. Ideal

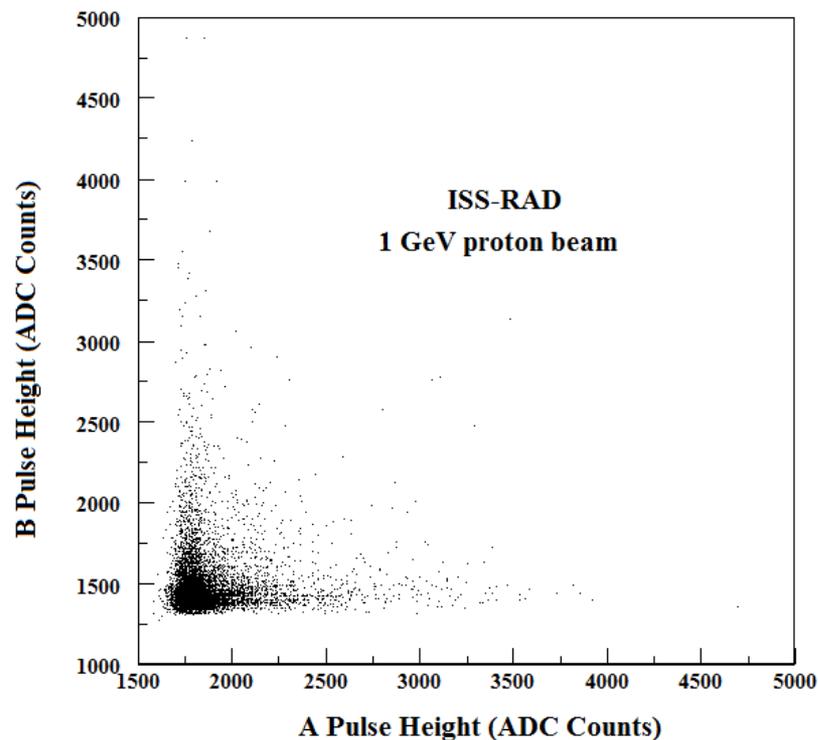
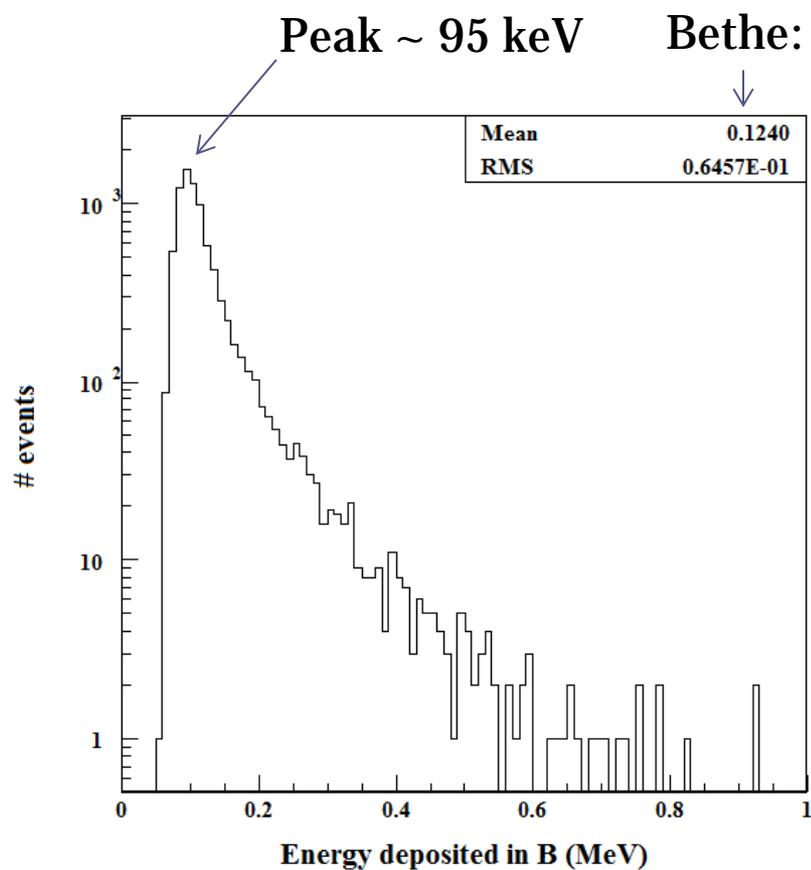
- Bethe formula is deterministic, gives $\langle dE/dx \rangle$.
- Full Vavilov probability distribution has same average as Bethe, $\langle LET \rangle_{\text{Vavilov}} = \langle dE/dx \rangle_{\text{Bethe}} = LET_{\infty}$.
- If distribution truncated, $\langle LET \rangle_{\text{Vavilov}} < LET_{\infty}$.
- Truncation of Vavilov distribution is a function of detector thickness and/or cuts made in data analysis.

Calibration of Thin Silicon Detectors



- If peaks from minimum-ionizing charge-1 particles are used for calibration, associate peak with “most probable” energy loss rather than the mean.
 - True both for flight data and accelerator data.

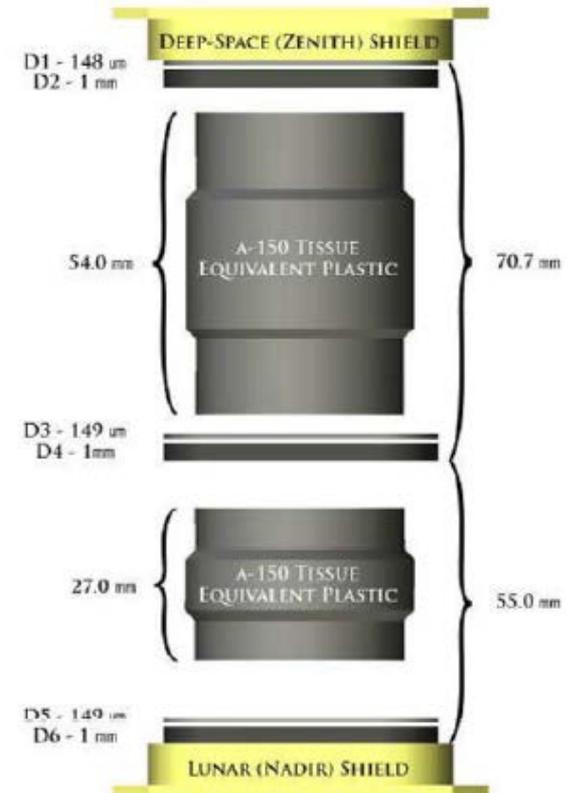
Data: 1 GeV protons in 300 μm Si



Compare Ions @ 1 GeV/nuc in CRaTER

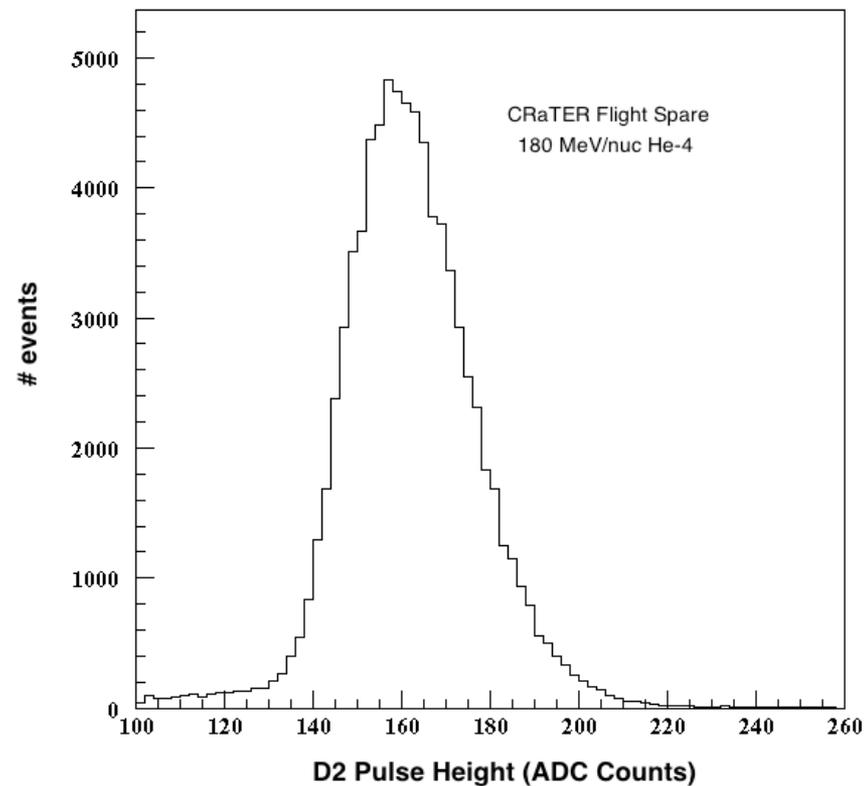
Ion	150 μm peak/average	1 mm peak/average
H	0.68	0.79
He	0.75	0.86
C	0.87	0.98
Mg	0.95	1.05
Fe	1.03	1.14

- Ratio always larger for thicker detector, increases as energy deposition increases.
- As peak \rightarrow mean, Vavilov \rightarrow Gaussian.
- **Peak/average values > 1 don't make sense.**



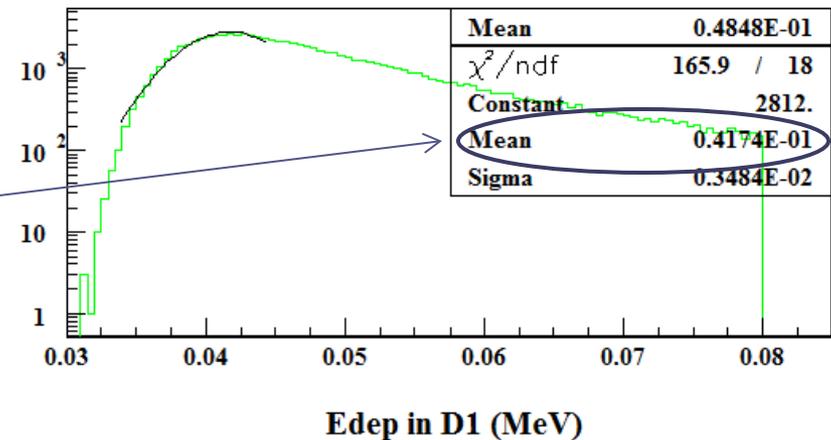
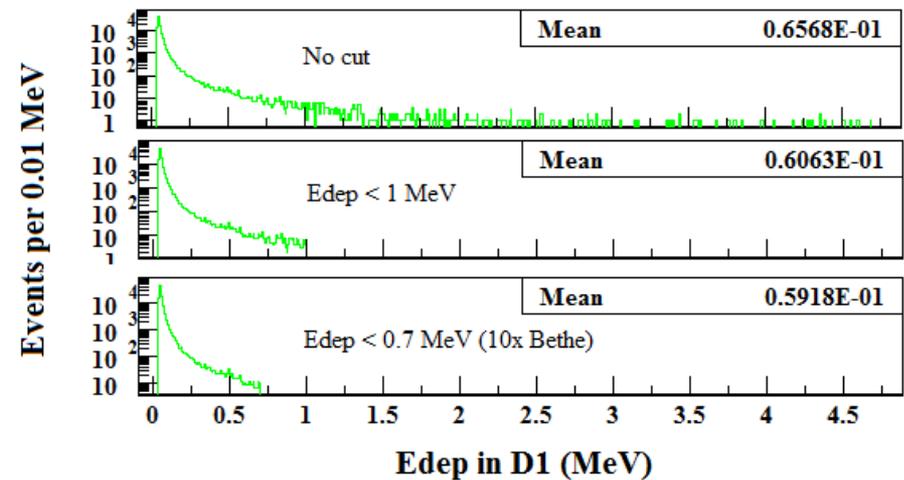
Calibration with Heavy Ions

- Problem: Vavilov formalism fails for $Z > 1$.
- See this in 180 MeV/nuc ^4He data from HIMAC in 2012 taken with CRaTER flight spare:
 - Measured ΔE distributions in 1 mm detectors are \sim Gaussian, predicted distributions are skewed.
- Probably best to use Bethe.



Vavilov Avg. vs. Bethe Formula

- Results for simulated 1 GeV protons on 148 μm of Si (D1 in CRaTER).
- Expected $\langle\Delta E\rangle$ from Bethe = 62 keV.
 - My code uses GEANT3 Landau distribution, gives ~ 66 keV (100k events).
- Mean shifts when high end tail is truncated \rightarrow Implications for dosimetry.
- As check of code, look for peak.
 - Find ~ 41.7 keV, Bichsel formula gives 42 keV.

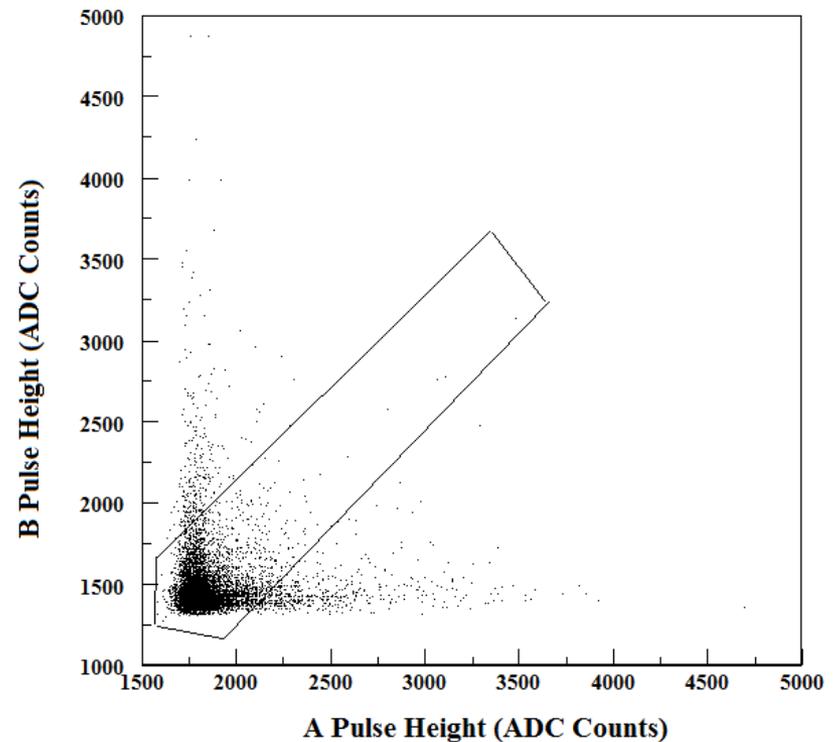


Underlying Physics

- High-end tail of energy deposition arises from rare collisions with large energy transfers to single e^- .
- $T_{max} \approx 2m_e\beta^2\gamma^2$ for ions.
- For example, @ 1 GeV/nuc, $(\beta\gamma) \sim 1$ so $T_{max} \sim 1$ MeV.
 - Range of 1 MeV e^- in Si = 2.3 mm.
 - 4 MeV ΔE in 148 μm of Si requires ~ 4 maximum-energy transfer collisions.
- Statistics of small numbers \rightarrow Poisson distribution.
 - Vavilov resembles Poisson.
 - As LET increases and/or detector gets thicker, “rare” collisions become less rare, Poisson \rightarrow normal.

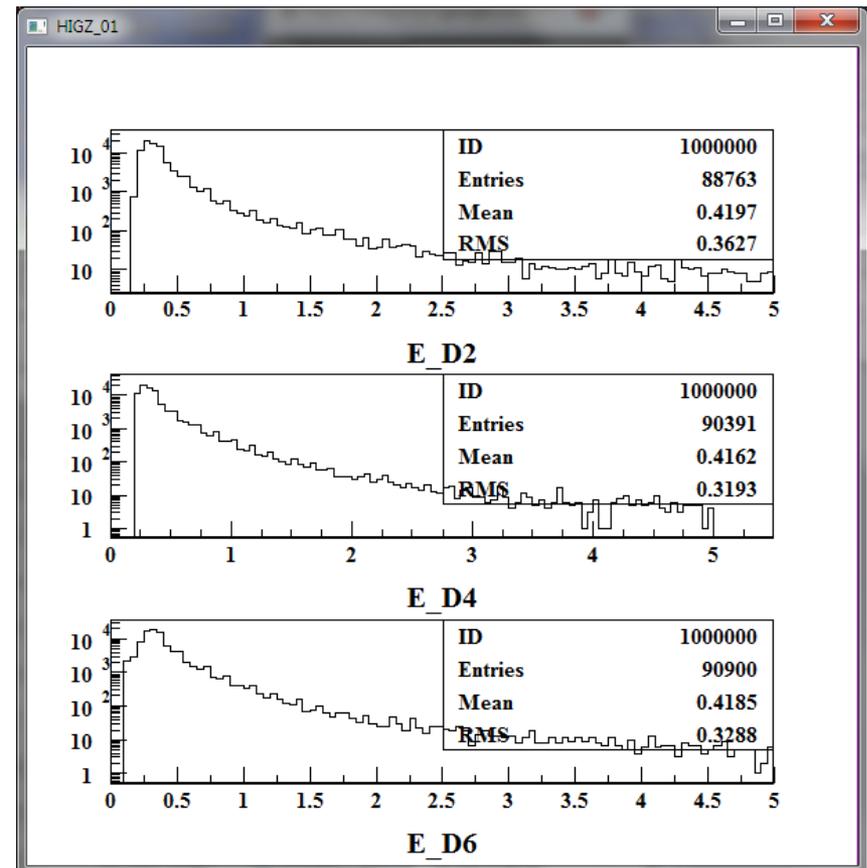
Truncation of Vavilov Distribution

1. Electrons escape & carry off energy – unavoidable.
2. In some analyses, require mutually consistent hits in detector pairs.
 - E.g., in MSL-RAD onboard LET spectrum, two detectors are checked and they must be mutually consistent to within a factor of 2.



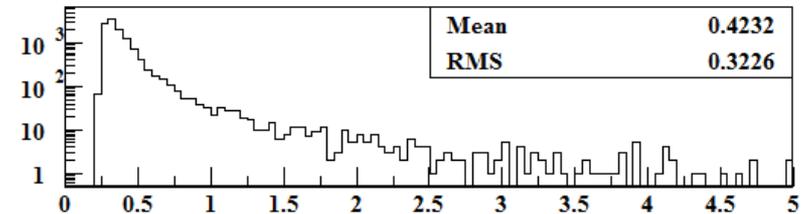
Vavilov Distributions in CRaTER Data

- Pick small, random GCR sample (Jan. 1-10, 2012).
- For D2 plot, require D4 and D6 to have 0.1 – 0.5 MeV ΔE , so we have high-energy charge-1 particles \sim parallel to detector axis.
- Similar for other plots.
- Get \sim same distribution in all 3, mean is \sim 0.42 MeV and RMS is \sim 0.3 MeV.

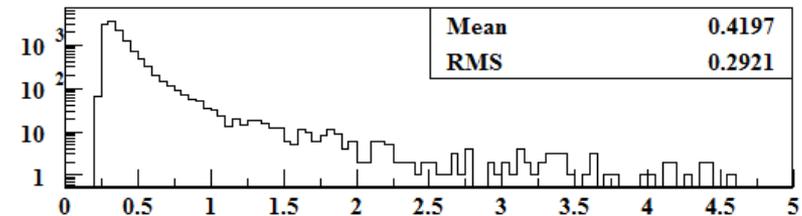


Compare to Simulated Protons

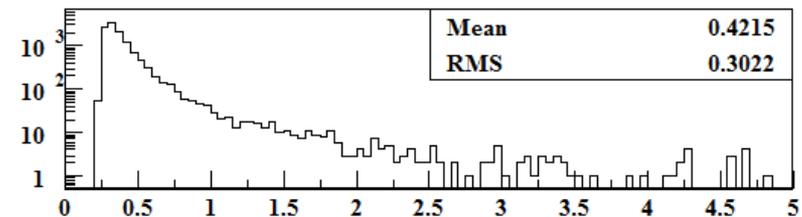
- 25k simulated GCR events.
- Distributions all drop off above 5 MeV in simulation.
 - Slightly truncated in code.
- Averages close to GCR data, RMS's ~ 10% smaller.
- Vavilov distributions are seen in flight data & they can be simulated reasonably well.



D2



D4



D6

Silicon to Water LET Conversion

Slide by M. Golightly

LET_{Si} → LET_{H₂O} Conversion

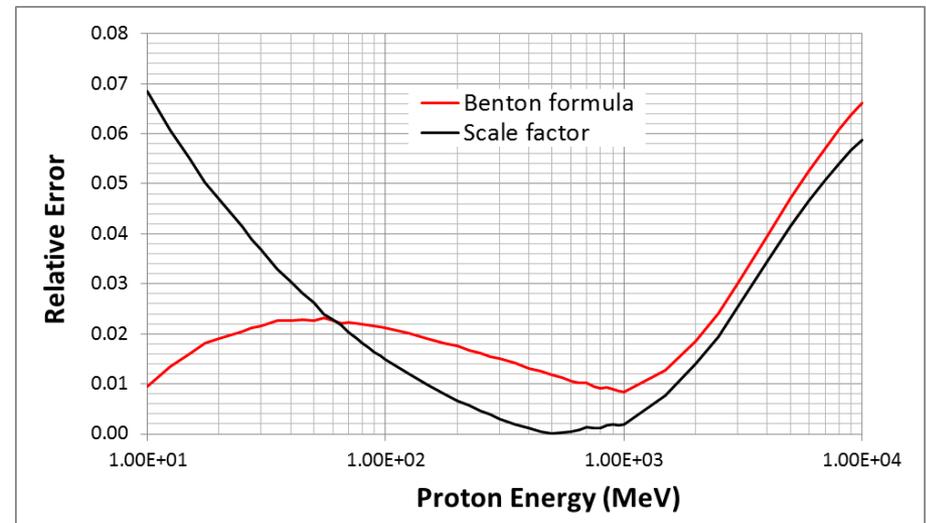
Benton, E.R., E.V. Benton, and A.L. Frank. "Conversion between different forms of LET." *Rad Meas*, **45(8)**, (2010) pp 957-9.

$$\log(\text{LET}_{\infty\text{H}_2\text{O}}) = -0.2902 + 1.025\log(\text{LET}_{\infty\text{Si}})$$

- Based on Henke and Benton's range/energy relations of ions in H₂O and Si (Henke and Benton, 1967; Benton and Henke, 1969)
 - Z = 1 to 26, E = 0.8-2000 MeV/amu
- Ratio LET_{∞H₂O} : LET_{∞Si} varies
 - 30% for E = 0.8-2000 MeV/amu
 - 5% for E = 50-2000 MeV/amu
- Functional relationship of LET_{∞H₂O} to LET_{∞Si} obtained from least squares fit to data

Fit vs. Simple Scaling for LET_{∞}

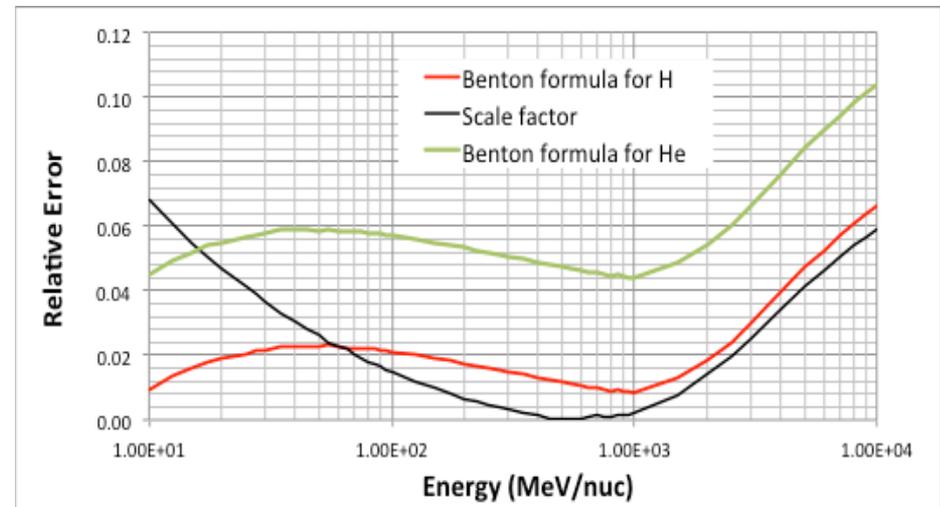
- Factor of ~ 1.23 is often used to multiply silicon dose to give tissue dose.
- For GCR it may be more accurate to use the simple scale factor.
- Benton formula has smaller errors below 50 MeV, but for $E > 80$ MeV, the scale factor is better (avg. err = 1.4% vs 2.3%).
 - Most GCRs have $E > 80$ MeV.
- May be best to use a hybrid for RAD & CRaTER data.



$$\text{Relative Error} = |\text{LET}_{\text{true}} - \text{LET}_{\text{calc}}| / \text{LET}_{\text{true}}$$

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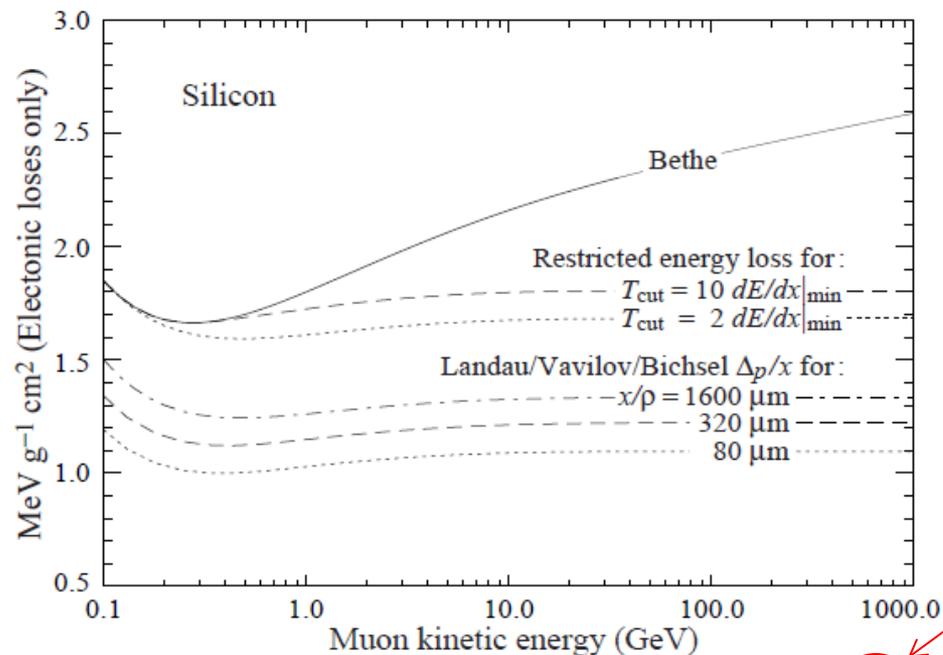
Recap

- Bethe formula gives correct average ΔE 's.
- Actual distributions are Vavilov for high-energy, low-charge ions.
 - Vavilov distribution has same mean as Bethe provided full distribution is captured.
- For dosimetry, escape of e^- or truncation by other means \rightarrow measured LET $<$ LET $_{\infty}$.
- Si to tissue factor of 1.23 assumes LET $_{\infty}$ in Si.

How to Correct for $LET < LET_{\infty}$?

- $LET < LET_{\infty} \rightarrow$ factor needs to be larger...but how much larger?
- In earlier simulations, I used restricted dE/dx to compensate for e^{-} escape.
 - Off a bit.

Restricted Energy Loss Theory & Implementation



Replaces
 T_{max}

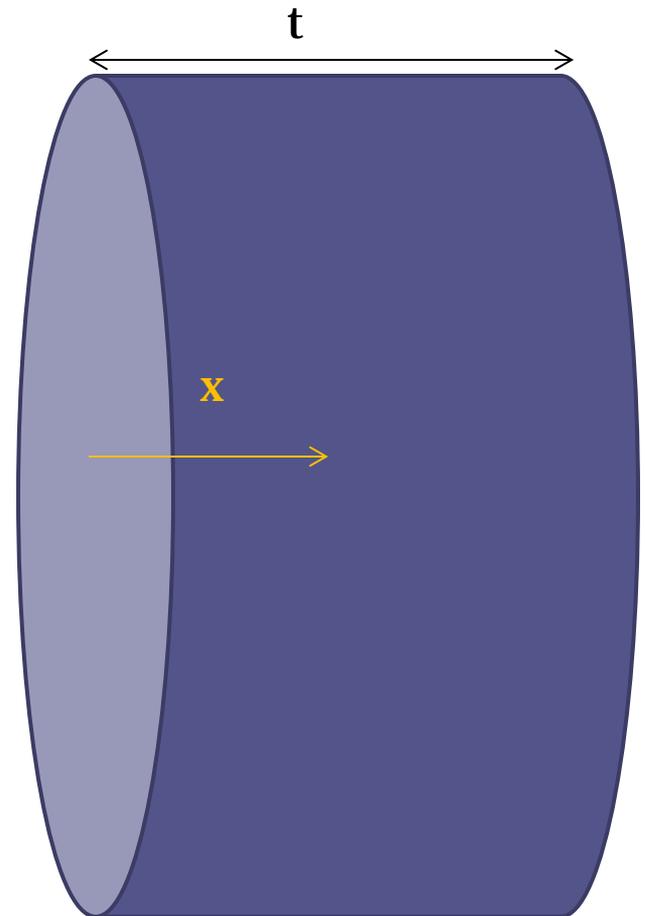
$T_{\text{max}} \approx 2m_e\beta^2\gamma^2$ for ions.

$$\left. -\frac{dE}{dx} \right|_{T < T_{\text{cut}}} = K z^2 \frac{Z}{A} \frac{1}{\beta^2} \left[\frac{1}{2} \ln \frac{2m_e c^2 \beta^2 \gamma^2 T_{\text{cut}}}{I^2} - \frac{\beta^2}{2} \left(1 + \frac{T_{\text{cut}}}{T_{\text{max}}} \right) - \frac{\delta}{2} \right]$$

Get Bethe formula
back if $T_{\text{cut}} = T_{\text{max}}$

What to Use for T_{cut} ?

- In simulation, particles are followed along paths through the detector in $1 \mu\text{m}$ steps.
- In each step, calculate energy of an electron (E) with range R equal to the remaining depth of the detector $E(R(t - x))$.
- This value is used for T_{cut} .
- **Overestimates escape.**
 - Treats delta-electrons as if they are forward-produced at exactly 0° .
 - Ignores multiple scattering.

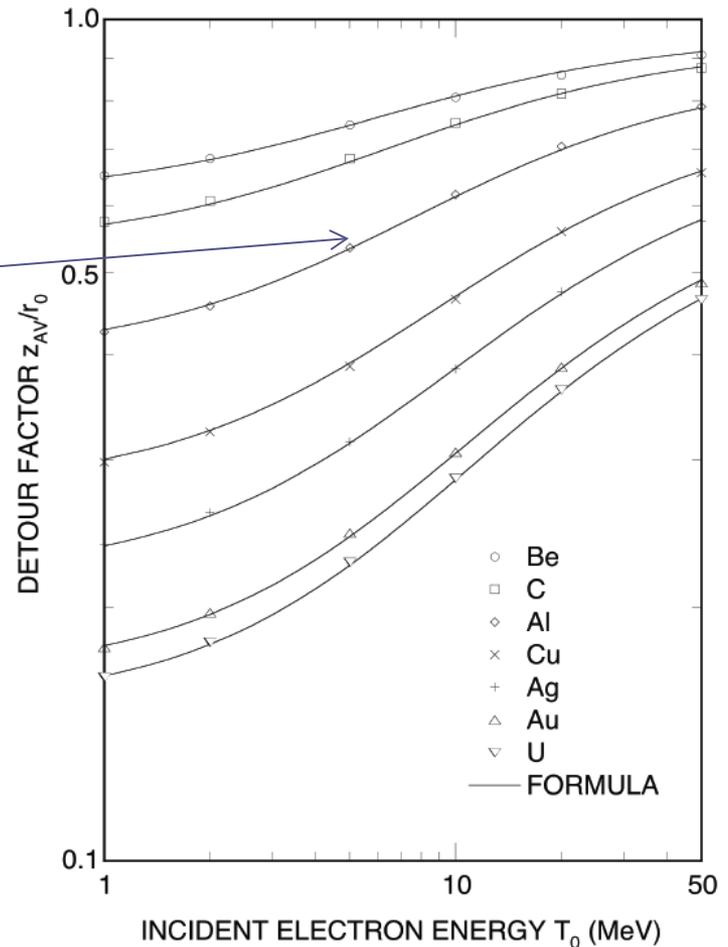


Upshot

- RAD cruise paper: Dose conversion factor of 1.45 (± 0.2) based on restricted dE/dx with low T_{cut} .
- Making T_{cut} more realistic changes this result.
 - Include approximation of “detour factor” for electrons.
 - Detour factor accounts for multiple scattering of e^- in the detector (tends to keep them in the detector).

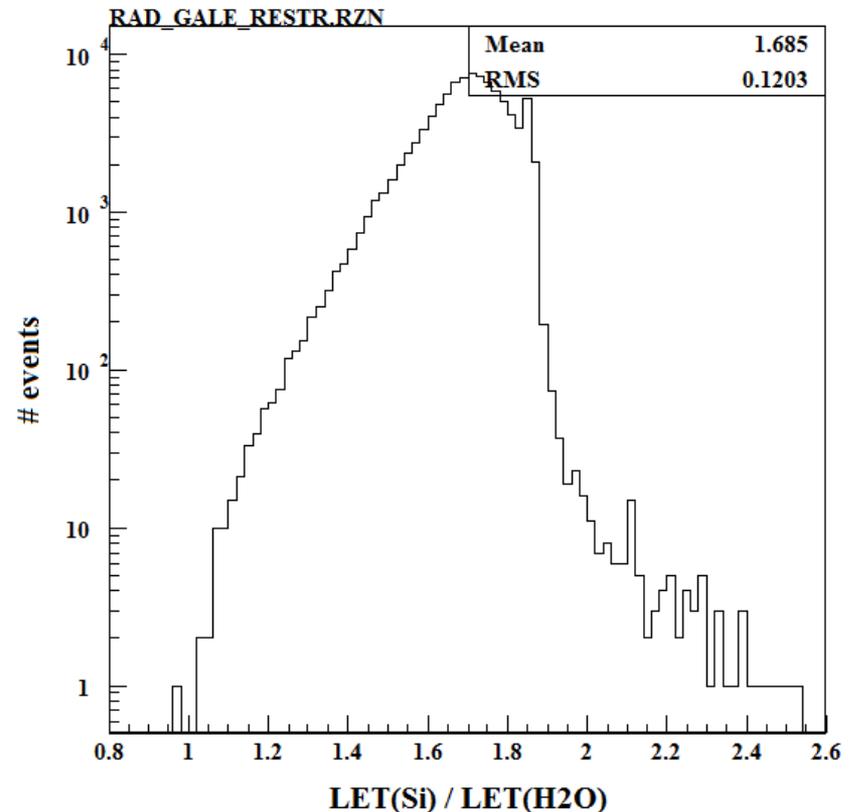
Tabata and Andreo (1998)

- Formula for detour factor in the 1-50 MeV range for electrons in elements.
- Aluminum close to Si. 
- Detour factor is projected range divided by CSDA range – projected paths are ~ factor of 2 shorter than nominal.
 - Put factor of 2 into code used to calculate T_{cut} in restricted energy loss formalism.

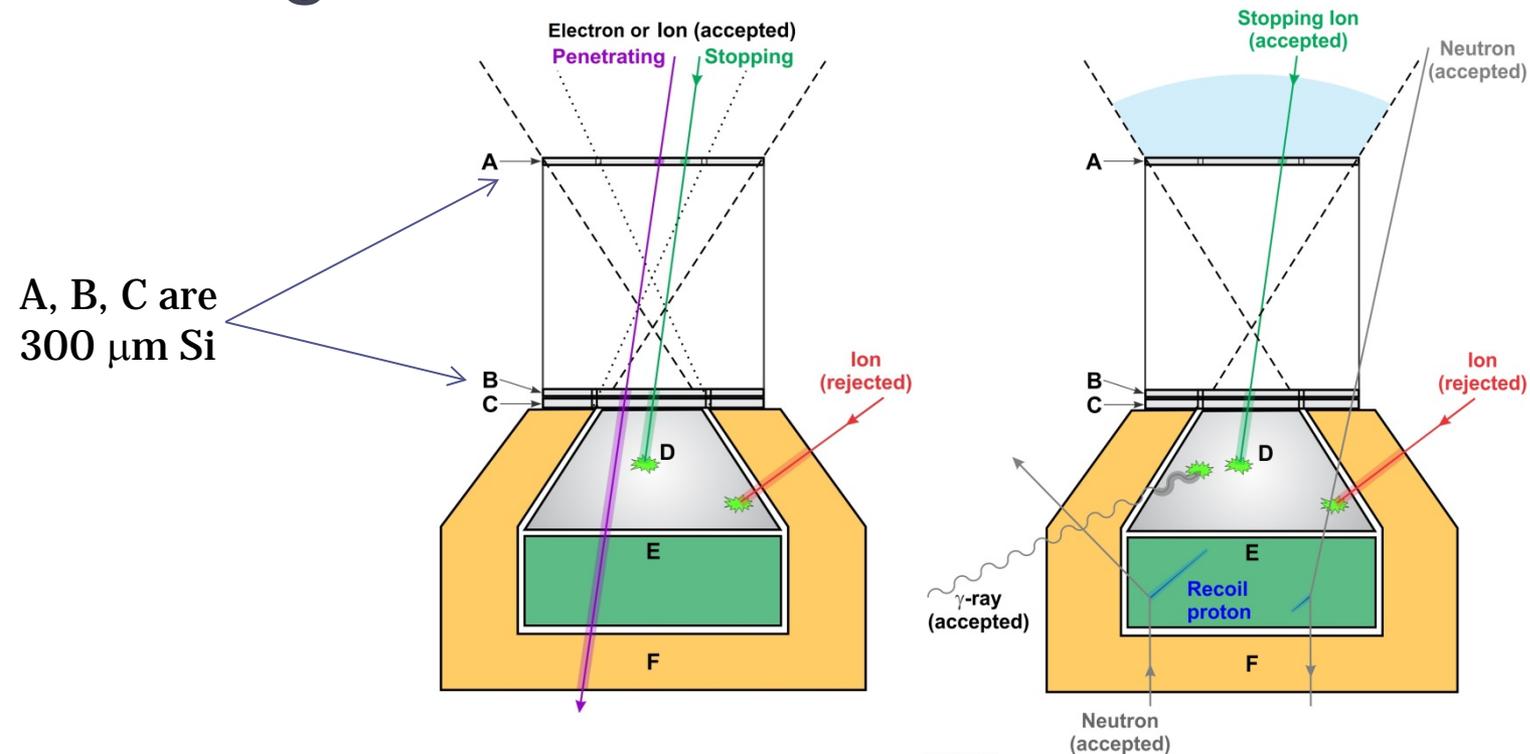


New RAD Simulation Result

- Simulate GCR (B-O spectrum) with 20 g cm^{-2} CO_2 above RAD.
- Compare LET in B detector to LET in water at entrance window above RAD.
- Dose conversion factor becomes $2.33/\text{Mean} = 1.38$.
 - Distribution asymmetric, RMS $\sim 7\%$ of mean.
- Check sensitivity of result to detour factor:
 - Value of 3 instead of 2 gives conversion factor of 1.36.



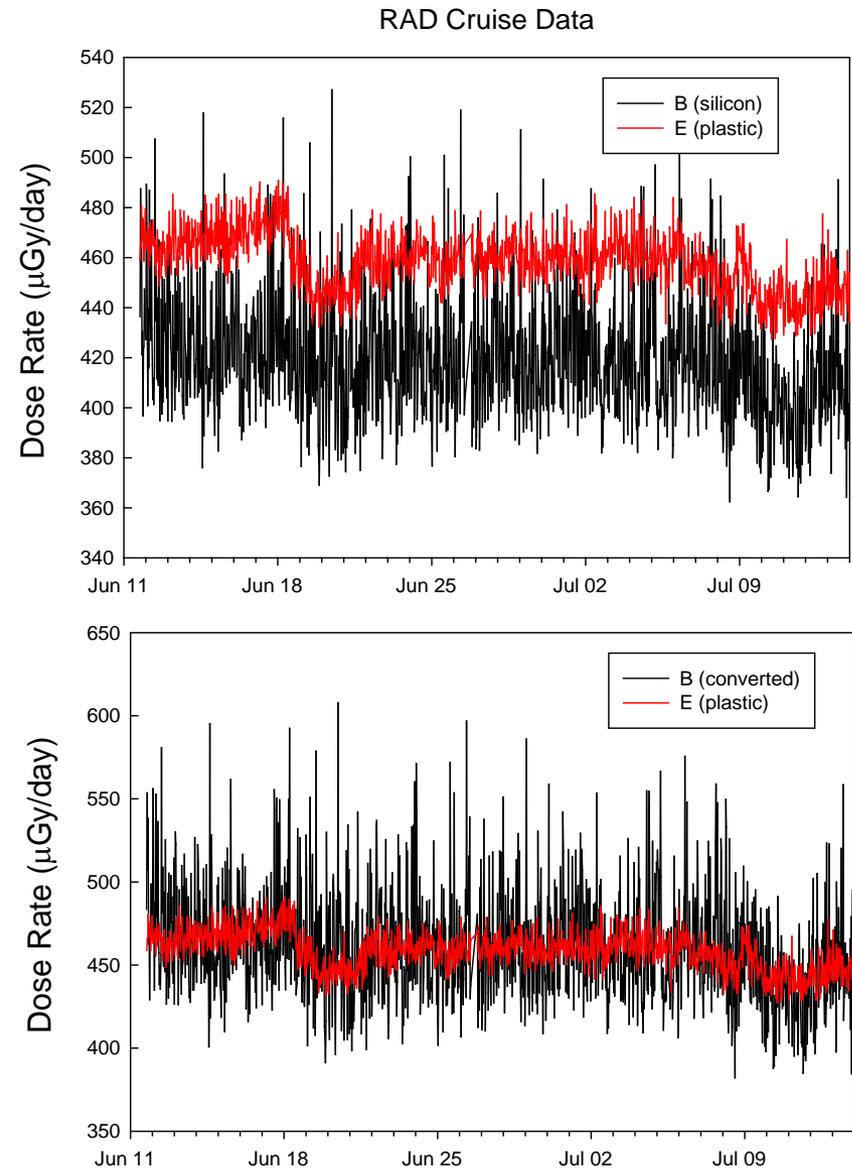
Insight from RAD Data



- RAD B (silicon) and E (plastic) detectors are used for dosimetry.
 - All hits above threshold contribute, regardless of hits in other detectors.
- Differences:
 - E misses some charged particle dose (stoppers in D or F).
 - E is more sensitive to neutrons, B is more sensitive to gammas.
 - Mass of E is $\sim 300\times$ mass of B.

RAD Cruise Data

- RAD was moderately shielded in cruise, $\sim 16 \text{ g cm}^{-2}$ on average.
- E dose was $\sim 98\%$ due to charged particles during solar quiet time with ~ 0 RTG background.
- E calibration is dominant uncertainty (quenching).
- Additional caveats:
 - B has RTG background.
 - Measured @ Cape; subtracted from flight data in lower plot.
 - E is plastic, not water (2% effect).
- Scale factor of 1.37 makes B and E average dose rates equal.



Conclusions, Next Steps

- Si \rightarrow water factor of 1.23 is too small because measured LET in Si $<$ LET $_{\infty}$.
- Si \rightarrow water factor of 1.45 for 300 μ m Si is too big (overestimated electron escape).
- Revised calculation with detour factor=2 \rightarrow 1.38.
- RAD data suggest 1.37, with several caveats.
- For CRaTER, factor is larger for thin detectors (150 μ m), smaller for thick (1 mm).
- Still working on simulation, RAD E calibration.